Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,519	DUBOIS, MICHEL	
Examiner	Art Unit	
Suk Jin Kang	2609	

SEARCHED			
Class	Subclass	Date	Examiner
370	388	4/27/2007	SJK
340	2.22	4/27/2007	SJK
	•		
			7-

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	4/27/2007	SJK
Inventor name and Assignee search in PALM ExPO and EAST	4/27/2007	SJK
Consulted with Rafael Perez-Gutierrez (SPE) and George Bugg	4/27/2007	SJK
(370/388, 370, 372.ccls.) or (340/2.2, 2.21, 2.22, 2.23.ccls.)	4/27/2007	SJK
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